

**Search Notes**

Application/Control No.

10/047,784

Examiner

J. Derek Rutten

Applicant(s)/Patent under  
Reexamination

BARKER ET AL.

Art Unit

2192

**SEARCHED**

Class	Subclass	Date	Examiner
717	105	2/26/2007	JDR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See search notes			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Tuan Dam (consulted re. allowable subject matter)	2/22/2007	JDR
US App. No. 10047312, 10047792, 10047793 (cited art)	2/22/2007	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	2/22/2007	JDR
717/104-109; 715/762,764 text search only See search history printout	2/22/2007	JDR
ACM - portal.acm.org IEEE - ieeexplore.ieee.org Google - www.google.com See search history printout	2/22/2007	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	2/26/2007	JDR
717/104-109; 715/764,764; 703/1 text search only See search history printout	2/26/2007	JDR